

**Search Notes**

Application/Control No.

10/678,061

Examiner

Chris C. Chu

Applicant(s)/Patent under  
Reexamination

IMAI ET AL.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	758, 774, 750 and 763	12/21/2004	C.C.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	12/21/2004	C.C.